MSKSEMI 美森科













ESD

TV

TSS

MOV

GDT

PIFD

BSS138BK

Product specification





Features

- 55V,0.3A, RDS(ON) =1.2Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

Applications

- Motor Drive
- Power Tools
- LED Lighting

BVDSS	RDSON	ID
55V	1.2Ω	0.3A

Reference News

PACKAGE OUTLINE	N-Channel MOSFET	Marking
SOT-23	G° T S	WSB **

Absolute Maximum Ratings (T_A=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	55	V
Vgs	Gate-Source Voltage	±20	V
L	Drain Current – Continuous (T₄=25°C)	0.3	А
lb	Drain Current – Continuous (T _A =70°C)	0.16	А
Ірм	Drain Current – Pulsed¹	0.8	Α
D-	Power Dissipation (T _A =25°C)	0.35	W
PD	Power Dissipation – Derate above 25°C	0.003	W/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		357	°C/W



Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=250uA	55			V
lpss	Drain-Source Leakage Current	V _{DS} =55V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Drain-Source Leakage Guirent	V _{DS} =40V , V _{GS} =0V , T _J =125°C			100	uA
Igss	Gate-Source Leakage Current	Vgs= ±20V , Vps=0V			±10	uA

On Characteristics

Process	Static Drain Source On Desistance	Vgs= 10V , Ip=0.2A		1.2	1.5	Ω
RDS(ON)	Static Drain-Source On-Resistance	Vgs=4.5V , Ip=0.1A		1.5	2.5	Ω
V _{GS(th)}	Gate Threshold Voltage	Vgs=Vps , Ip =250uA	0.8	1.1	1.5	V
gfs	Forward Transconductance	Vps= 10V , Ip=0.2A		0.5		S

Dynamic and switching Characteristics

•	•			
Qg	Total Gate Charge ^{2, 3}		 3.7	
Qgs	Gate-Source Charge ^{2, 3}	V _{DS} =30V , V _{GS} =10V , I _D =0.2A	 0.9	 nC
Qgd	Gate-Drain Charge ^{2, 3}		 0.4	
T _{d(on)}	Turn-On Delay Time ^{2,3}		 3	
Tr	Rise Time ² , ³	V_{DD} =30 V , V_{GS} =10 V , R_{G} =6 Ω	 5	
T _{d(off)}	Turn-Off Delay Time ^{2,3}	lp=0.2A	 14	 ns
Tf	Fall Time ^{2 , 3}		 9	
Ciss	Input Capacitance		 25.5	
Coss	Output Capacitance	V _{DS} =30V , V _{GS} =0V , F=1MHz	 17	 pF
Crss	Reverse Transfer Capacitance		 7.8	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V, Force Current			0.3	Α
lsм	Pulsed Source Current	VG-VD-UV, FOICE Current			0.6	Α
Vsd	Diode Forward Voltage	Vgs=0V , Is=0.2A , TJ=25°C			1.4	V
t _{rr}	Reverse Recovery Time	V _R =50V, I _S =0.2A		3.4		ns
Qrr	Reverse Recovery Charge	dl/dt= 100A/µs, Tյ=25°C		0.7		nC

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leqq 300us , duty cycle $\,\leqq\,$ 2%.
- 3. Essentially independent of operating temperature.

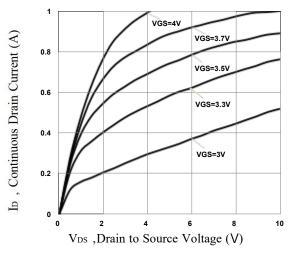


Fig. 1 Typical Output Characteristics

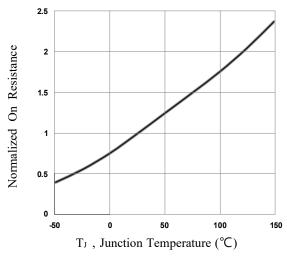


Fig. 3 Normalized RDSON vs. T_J

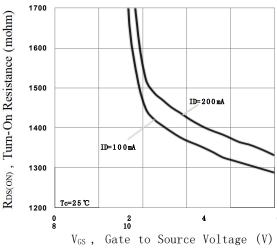


Fig. 5 $\,$ Turn-On Resistance vs. V_{GS}

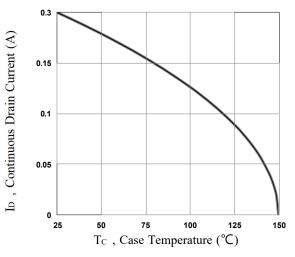
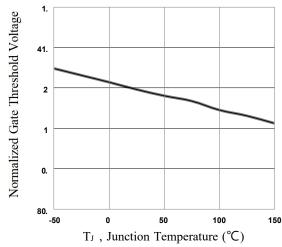


Fig. 2 Continuous Drain Current vs. T_C



 $^{\bf 60}{\rm Fig.~4}$ Normalized $V_{\rm th}$ vs. T_J

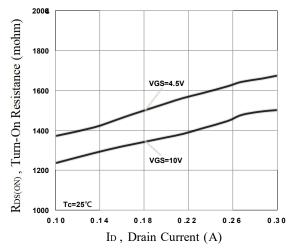


Fig. 6 Turn-On Resistance vs. ID

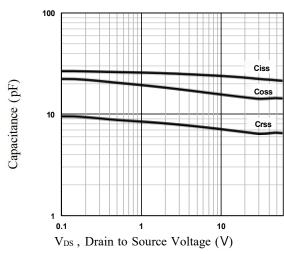
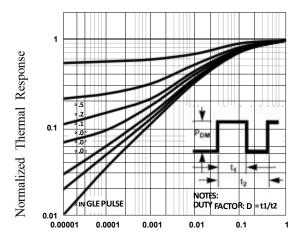


Fig. 7 Capacitance Characteristics



Square Wave Pulse Duration (s)

Fig. 9 Normalized Transient

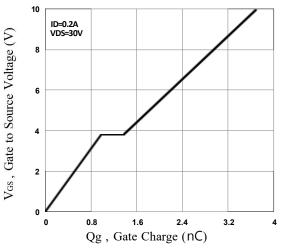
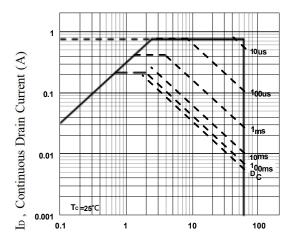


Fig. 8 Gate Charge Characteristics

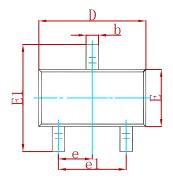


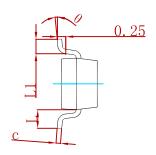
V_{DS}, Drain to Source Voltage (V)

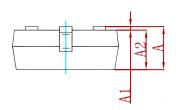
Fig. 10 Maximum Safe Operation Area



PACKAGE MECHANICAL DATA

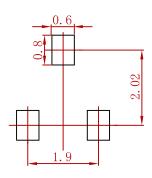






Cumbal	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550	REF	0.022 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

REELSPECIFICATION

P/N	PKG	QTY
BSS138BK	SOT-23	3000



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